

Search Notes

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10/535,397

Examiner

Francis T. Palo

Applicant(s)/Patent under
Reexamination

AIBA, TOSHIYUKI

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search Attached		3/4/2007	FP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR